Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/619,577	FUJII ET AL.	
Examiner	Art Unit	
Thinh H. Nguyen	2861	

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Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
347/9-13,57,59 text search only; Printout enclosed	8/30/2005	TN
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